

STC5NF30V

N-channel 30V - 0.027Ω - 5A - TSSOP8 2.7V-drive STripFET™ II Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D
STC5NF30V	30V	< 0.031 Ω(@ 4.5 V) < 0.035 Ω(@ 2.7 V)	5A

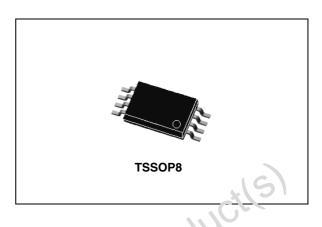
- Ultra low threshold gate drive (2.7V)
- Standard outline for easy automated surface mount assembly

Description

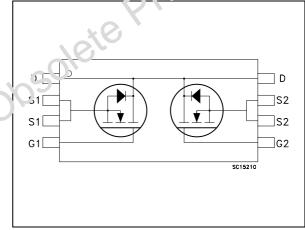
This Power MOSFET is the latest development of STMicroelectronis unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

Applications

Switching application
Froduction



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STC5NF30V	C5NF30V	TSSOP8	

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Electrical ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V
V _{DGR}	Drain-gate voltage ($R_{GS} = 20K\Omega$)	20	V
V _{GS}	Gate-source voltage	± 12	V
Ι _D	Drain current (continuous) at $T_C = 25^{\circ}C$	5	Α
Ι _D	Drain current (continuous) at T _C =100°C	3	А
I _{DM} ⁽¹⁾	Drain current (pulsed)	20	А
P _{TOT}	Total dissipation at $T_{C} = 25^{\circ}C$	1.5	W
T _{stg}	Storage temperature	-55 to 150	°C
TJ	Max. operating junction temperature	-55 to 150	°C
1. Pulse w	vidth limited by safe operating area	o duct	
Symbol	Parameter	Value	Unit

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R _{thJ-PBC}	Thermal resistance junction-PBC Max	100 (1)	°C/W
R _{thJ-PBC}	Thermal resistance junction-PBC Max	83.5 ⁽²⁾	°C/W

1. When Mounted on FR-4 board with 1 inch² pad, 2 oz of Cu and t = 10 sec

2. When Mounted on minimum recommended footprint .m obsolete production

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Electrical characteristics 2

(T_{CASE}=25°C unless otherwise specified)

	0.401.000					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 250μΑ, V _{GS} = 0	30			V
I _{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	V _{DS} = Max rating, V _{DS} = Max rating @125°C			1 10	μA μA
I _{GSS}	Gate body leakage current (V _{DS} = 0)	$V_{GS} = \pm 12V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.6			V
R _{DS(on)}	Static drain-source on resistance	V_{GS} = 4.5V, I _D = 2.5A V _{GS} =2.7V, I _D = 2.5A		0.027 0.031	0.031 0.035	Ω Ω
Table 4.	Dynamic			90	5	
Symbol	Parameter	Test conditions	Min	Typ	Max	Unit

On/off states Table 3.

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 2.5 \text{ A}$	-	9.5		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =15V, f = 1 MHz, V _{GS} = 0		460 200 50		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 16V, I_D = 4.5A$ $V_{GS} = 4.5V$ Figure 15 on page 8		8.5 1.8 2.4	11.5	nC nC nC

1. Pulsed: pulse duration=300µs, duty cycle 1.5%

Switching times Table 5.

	Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Obsole	t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 10V, I_D = 2.5A, R_G =4.7 Ω , V_{GS} =4.5V <i>Figure 13 on page 8</i>		7 33 27 10		ns ns ns ns
	t _{d(off)} t _f t _c	Off-voltage rise time Fall time Cross-over time	$ \begin{array}{l} \mbox{Vclamp} = 16\mbox{V}, \mbox{I}_D = 5\mbox{A} \\ \mbox{R}_G = 4.7\mbox{\Omega}, \mbox{V}_{GS} = 4.5\mbox{V} \\ \hline \mbox{Figure 15 on page 8} \end{array} $		26 11 21		ns ns ns

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				5	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				20	А
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD} = 5A, V_{GS} = 0$			1.2	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 5A, di/dt = 100A/μs, V _{DD} = 10V, T _J = 150°C <i>Figure 15 on page 8</i>		26 13 1		ns μC Α

 Table 6.
 Source drain diode

1. Pulse width limited by safe operating area

obsolete Product(s) - Obsolete Product(s) 2. Pulsed: pulse duration=300µs, duty cycle 1.5%



Electrical characteristics (curves) 2.1

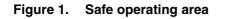
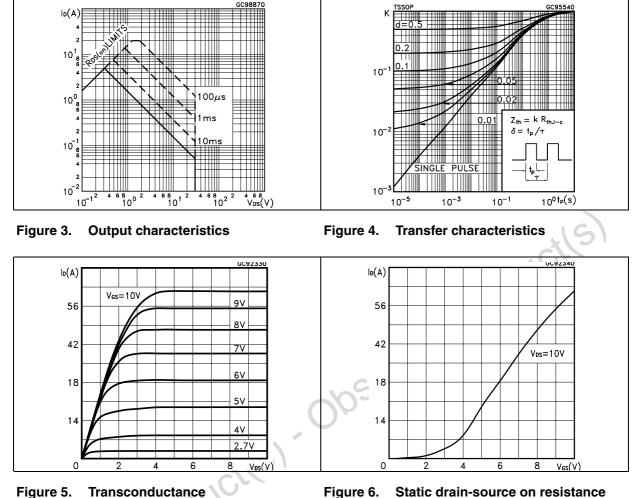
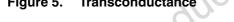


Figure 2. **Thermal impedance**







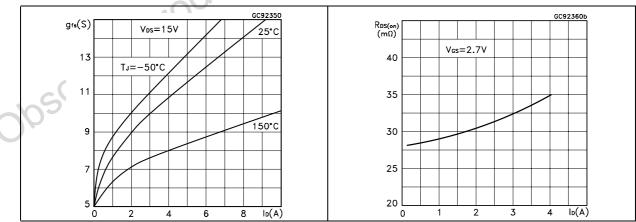
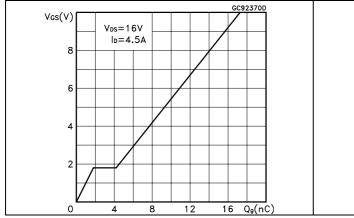


Figure 7.



Gate charge vs gate-source voltage Figure 8.

Figure 9. Normalized gate threshold voltage I vs temperature

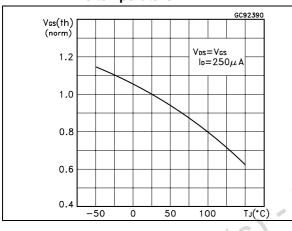
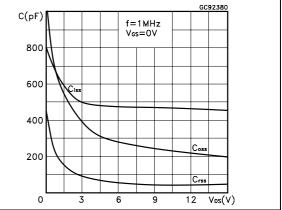


Figure 11. Source-drain diode forward characteristics



Capacitance variations

Figure 10. Normalized on resistance vs temperature

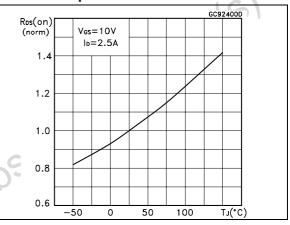
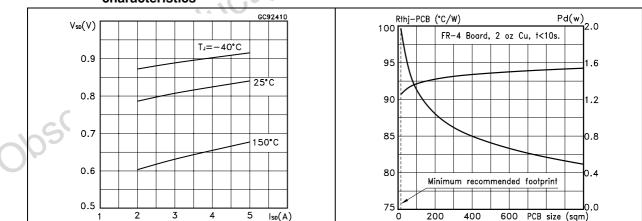
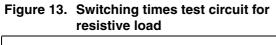


Figure 12. Thermal resistance and max power



3 Test circuit



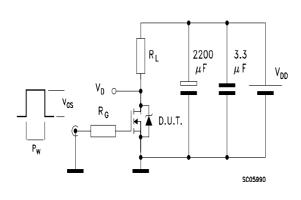


Figure 15. Test circuit for inductive load switching and diode recovery times

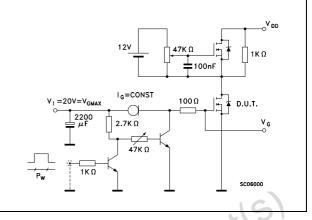
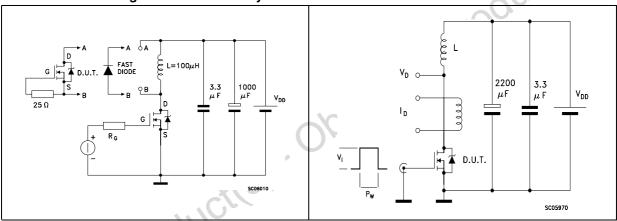
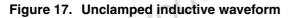
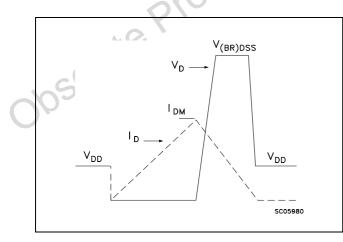


Figure 14. Gate charge test circuit









4 Package mechanical data

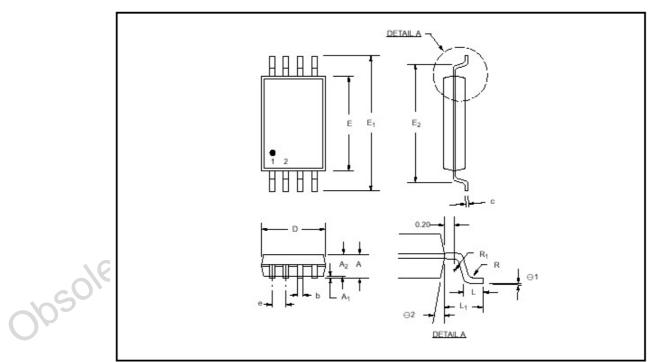
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obsolete Product(s). Obsolete Product(s)

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DIM	mm.			inch			
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX	
Α	1.05		1.20	0.041		0.047	
A1	0.05		0.15	0.002		0.006	
A2	0.80		1.05	0.032		0.041	
b	0.19		0.30	0.008		0.012	
с		0.127			0.005		
D	2.90		3.10	0.114		0.122	
E	4.30		4.50	0.170		0.177	
E1	6.20		6.60	0.240		0.260	
E2	5.14		5.24	0.202		0.206	
е		0.65			0.025		
L	0.45		0.75	0.018		0.030	
L1	0.90		1.10	0.0355		0.0433	
R	0.09			0.004			
R1	0.09			0.004			
01	0°		8°	0°		8°	



TSSOP8 MECHANICAL DATA

5 Revision history

Table 7.	Revision	history
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Date	Revision	Changes
09-Sep-2004	1	First release
08-Aug-2006	2	New template, SOA updated

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